


<p style="text-align: center;">Search Notes</p> 	<p>Application/Control No.</p> <p>10532895</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>BEJEAN, ALAIN</p>
	<p>Examiner</p> <p>MATTHEW T HENNING</p>	<p>Art Unit</p> <p>2431</p>

SEARCHED			
Class	Subclass	Date	Examiner
726	20	1/30/2009, 9/15/2009, 7/26/2010	MTH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST(USPAT; USPGPUB; IBMTDB; DERWENT)	1/30/2009, 9/16/2009, 7/23/2010	MTH
Inventor Name Search	1/30/2009, 9/15/2009, 7/23/2010	MTH
PLUS Search	1/21/2009	MTH
Text Search 340/5.23,5.24,5.64,5.71,825.69,825.72	7/26/2010	MTH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	<p>/MATTHEW T HENNING/ Primary Examiner.Art Unit 2431</p>
--	---